

TOSHIBA TRANSISTOR SILICON PNP EPITAXIAL TYPE (PCT PROCESS)

2SA1316

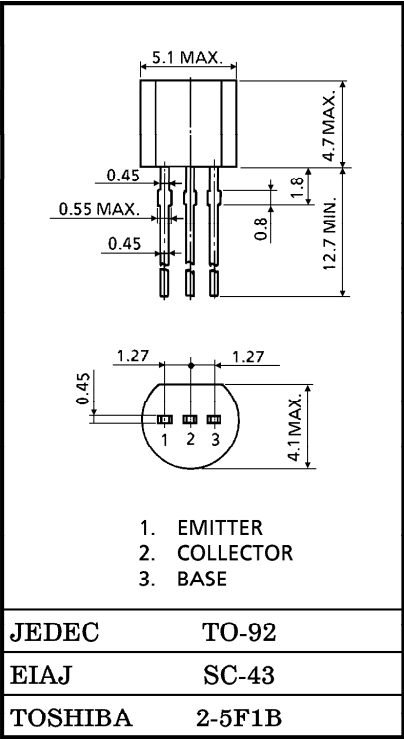
FOR LOW NOISE AUDIO AMPLIFIER APPLICATIONS AND
RECOMMENDED FOR THE FIRST STAGES OF MC HEAD AMPLIFIERS

- Very Low Noise in the Region of Low Signal Source Impedance
Equivalent Input Noise Voltage : $E_n=0.6nV / \sqrt{Hz}$ (Typ.)
- Low Pulse Noise. Low 1 / f Noise
- Low Base Spreading Resistance : $r_{bb'}=2.0\Omega$ (Typ.)
- Complementary to 2SC3329

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	V _{CBO}	−80	V
Collector-Emitter Voltage	V _{CEO}	−80	V
Emitter-Base Voltage	V _{EBO}	−5	V
Collector Current	I _C	−100	mA
Base Current	I _B	−20	mA
Collector Power Dissipation	P _C	400	mW
Junction Temperature	T _j	125	°C
Storage Temperature Range	T _{stg}	−55~125	°C

Unit in mm



Weight : 0.21g

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = -80V, I_E = 0$	—	—	-0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$	—	—	-0.1	μA
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C = -1mA, I_B = 0$	-80	—	—	V
DC Current Gain	h_{FE} (Note)	$V_{CE} = -6V, I_C = -2mA$	200	—	700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$	—	—	-0.1	V
Base-Emitter Voltage	V_{BE}	$V_{CE} = -6V, I_C = -2mA$	—	-0.6	—	V
Base Spreading Resistance	$r_{bb'}$	$V_{CE} = -6V, I_C = -1mA, f = 100MHz$	—	2.0	—	Ω
Transition Frequency	f_T	$V_{CE} = -6V, I_C = -1mA, f = 100MHz$	—	50	—	MHz
Collector Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0, f = 1MHz$	—	6.2	—	pF
Noise Figure	NF	$V_{CE} = -6V, I_C = -0.1mA, f = 10Hz, R_G = 10k\Omega$	—	1	6	dB
		$V_{CE} = -6V, I_C = -0.1mA, f = 1kHz, R_G = 10k\Omega$	—	0.5	2	
		$V_{CE} = -6V, I_C = -0.1mA, f = 1kHz, R_G = 100\Omega$	—	2.5	—	

Note : h_{FE} Classification GR : 200~400, BL : 350~700

